

P 通道 NexFET™ 功率 MOSFET

 查询样品: **CSD25213W10**

特性

- 超低栅极电荷 (**Qg**) 和栅漏电荷 (**Qgd**)
- 小尺寸封装 **1mm x 1mm**
- 低高度 (高度为 **0.62mm**)
- 无铅
- 栅 - 源电压钳位
- 栅极静电放电 (**ESD**) 保护
- 符合 **RoHS** 环保标准
- 无卤素

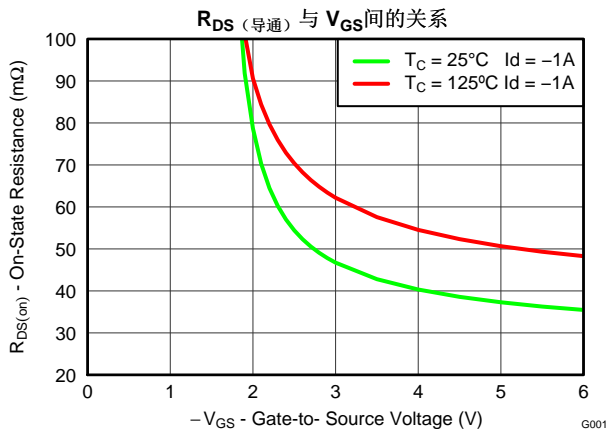
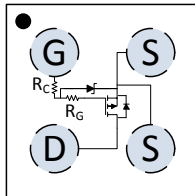
应用范围

- 电池管理
- 负载开关
- 电池保护

说明

此器件设计用于在超低高度并具有出色散热特性的尽可能小外形尺寸封装内产生最低的导通电阻和栅极电荷。

顶视图



产品概述

V_{DS}	漏源电压	-20	V
Q_g	栅极电荷总量 (4.5V)	2.2	nC
Q_{gd}	栅漏栅极电荷	0.14	nC
$R_{DS(on)}$ (导通)	漏源导通电阻	$V_{GS} = -2.5V$	54 mΩ
		$V_{GS} = -4.5V$	39 mΩ
$V_{GS(th)}$	阈值电压	-0.85	V

订购信息

器件	封装	介质	数量	出货
CSD25213W10	1 × 1 晶圆级封装	7 英寸卷带	3000	卷带封装

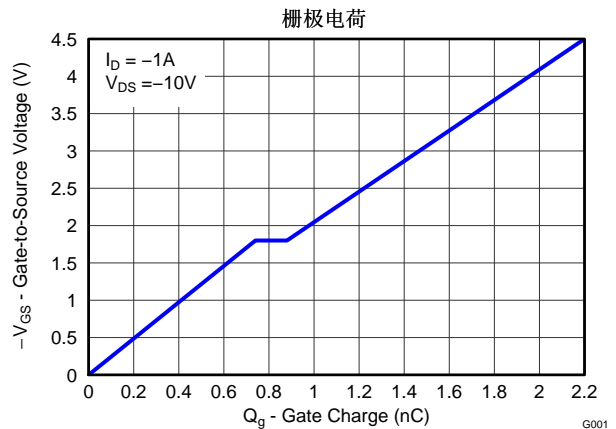
绝对最大额定值

$T_A = 25^\circ\text{C}$ 时测得, 除非另外注明		值	单位
V_{DS}	漏源电压	-20	V
V_{GS}	栅源电压	-6.0	V
I_D	持续漏极电流, $T_A = 25^\circ\text{C}$ 时测得 ⁽¹⁾	-1.6	A
I_{DM}	脉冲漏极电流, $T_A = 25^\circ\text{C}$ 时测得 ⁽²⁾	-16	A
I_G	持续栅极钳位电流 ⁽³⁾	-5	mA
P_D	功率耗散 ⁽¹⁾	1	W
T_J, T_{STG}	运行结温和储存温度范围	-55 至 150	$^\circ\text{C}$

(1) 在 1 in^2 盎司纯铜 (Cu) (2 oz.) 且厚度为 $0.060''$ 的环氧板 (FR4) 印刷电路板 (PCB) 上, $R_{\theta JA} = 75^\circ\text{C}/\text{W}$ 。

(2) 脉宽 $\leq 300\mu\text{s}$, 占空比 $\leq 2\%$

(3) 受栅极电阻限制。



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ELECTRICAL CHARACTERISTICS

($T_A = 25^\circ\text{C}$ unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static Characteristics						
BV_{DSS}	Drain to Source Voltage	$V_{GS} = 0V, I_D = -250\mu A$	-20			V
BV_{GSS}	Gate to Source Voltage;	$V_{DS} = 0V, I_G = -250\mu A$	-6.0			V
I_{DSS}	Drain to Source Leakage Current	$V_{GS} = 0V, V_{DS} = -10V$			-1	μA
I_{GSS}	Gate to Source Leakage Current	$V_{DS} = 0V, V_{GS} = -6V$			-100	nA
$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.60	-0.85	-1.10	V
$R_{DS(on)}$	Drain to Source On Resistance	$V_{GS} = -2.5V, I_D = -1A$		54	67	m Ω
		$V_{GS} = -4.5V, I_D = -1A$		39	47	m Ω
g_{fs}	Transconductance	$V_{DS} = -10V, I_D = -1A$		6.2		S
Dynamic Characteristics						
C_{ISS}	Input Capacitance	$V_{GS} = 0V, V_{DS} = -10V, f = 10kHz$		368	478	pF
C_{OSS}	Output Capacitance			148	192	pF
C_{RSS}	Reverse Transfer Capacitance			7.8	10.1	pF
R_G	Series Gate Resistance			20		Ω
R_C	Series Clamp Resistance			5000		Ω
Q_g	Gate Charge Total (-4.5V)	$V_{DS} = -10V, I_D = -1A$		2.2	2.9	nC
Q_{gd}	Gate Charge Gate to Drain			0.14		nC
Q_{gs}	Gate Charge Gate to Source			0.74		nC
$Q_{g(th)}$	Gate Charge at V_{th}			0.43		nC
Q_{OSS}	Output Charge	$V_{DS} = -10V, V_{GS} = 0V$		2.5		nC
$t_{d(on)}$	Turn On Delay Time	$V_{DS} = -10V, V_{GS} = -2.5V, I_D = -1A$ $R_G = 10\Omega$		510		ns
t_r	Rise Time			520		ns
$t_{d(off)}$	Turn Off Delay Time			1000		ns
t_f	Fall Time			970		ns
Diode Characteristics						
V_{SD}	Diode Forward Voltage	$I_S = -1A, V_{GS} = 0V$		-0.77	-1	V
Q_{rr}	Reverse Recovery Charge	$V_{DS} = -10V, I_F = -1A,$ $di/dt = 200A/\mu s$		4.0		nC
t_{rr}	Reverse Recovery Time	$V_{DS} = -10V, I_F = -1A,$ $di/dt = 200A/\mu s$		11		ns

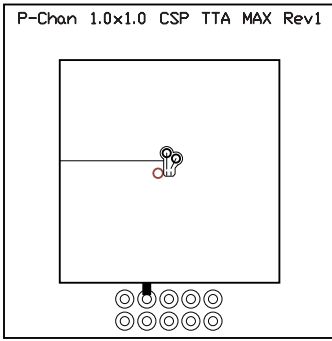
THERMAL CHARACTERISTICS

($T_A = 25^\circ\text{C}$ unless otherwise stated)

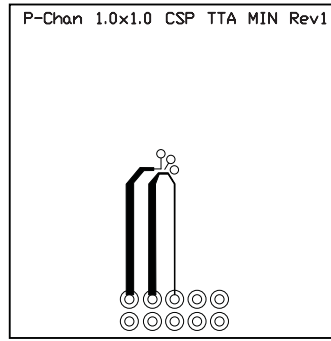
PARAMETER		MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Junction to Ambient Thermal Resistance ⁽¹⁾		75		$^\circ\text{C/W}$
	Junction to Ambient Thermal Resistance ⁽²⁾		265		$^\circ\text{C/W}$

(1) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.

(2) Device mounted on FR4 material with minimum Cu mounting area.



Max $R_{\theta JA} = 90^{\circ}\text{C/W}$
when mounted on
1 inch² of 2 oz. Cu.



Max $R_{\theta JA} = 333^{\circ}\text{C/W}$
when mounted on
minimum pad area of 2
oz. Cu.

TYPICAL MOSFET CHARACTERISTICS

($T_A = 25^{\circ}\text{C}$ unless otherwise stated)

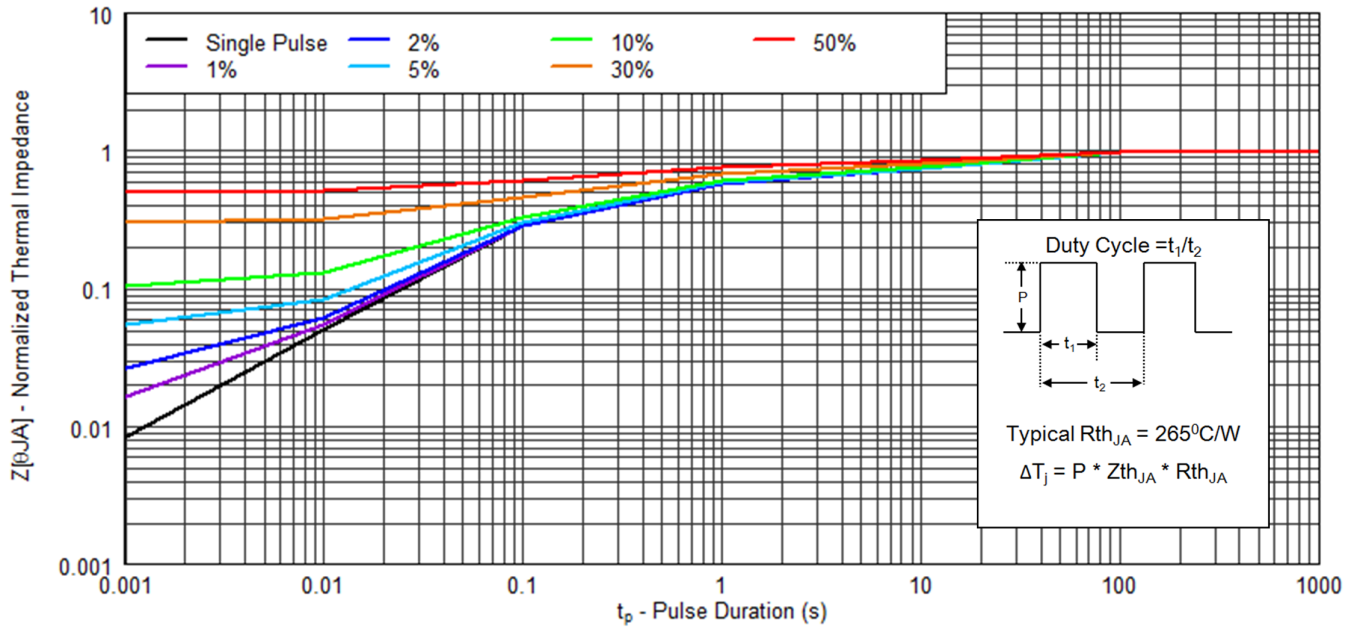


Figure 1. Transient Thermal Impedance

TYPICAL MOSFET CHARACTERISTICS (continued)

($T_A = 25^\circ\text{C}$ unless otherwise stated)

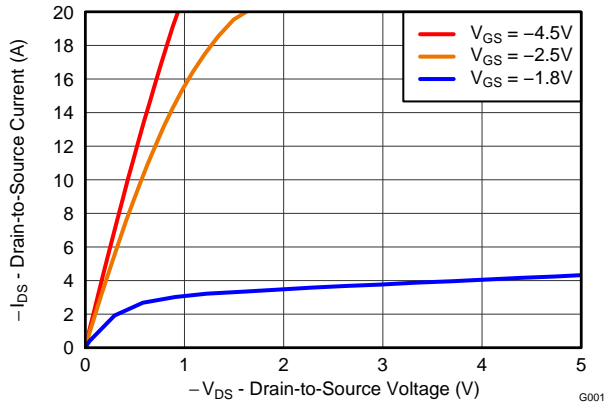


Figure 2. Saturation Characteristics

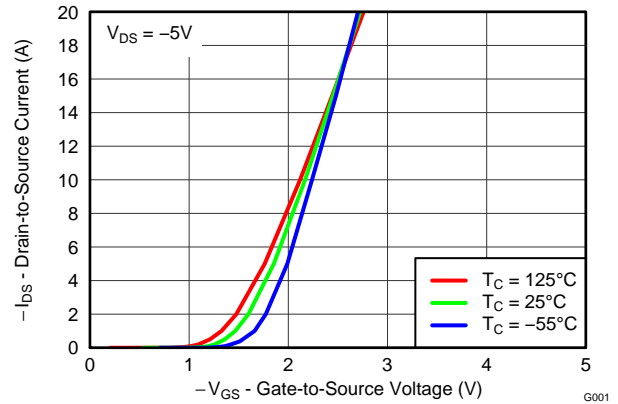


Figure 3. Transfer Characteristics

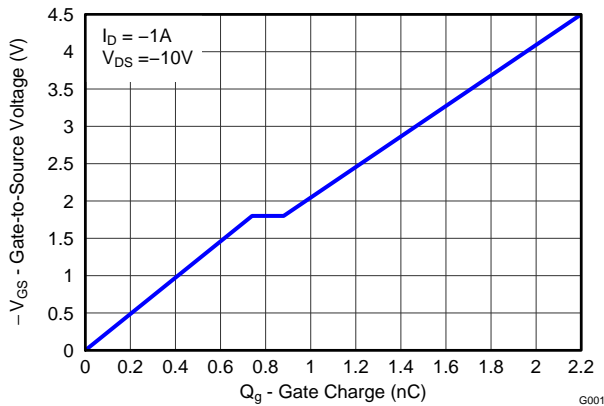


Figure 4. Gate Charge

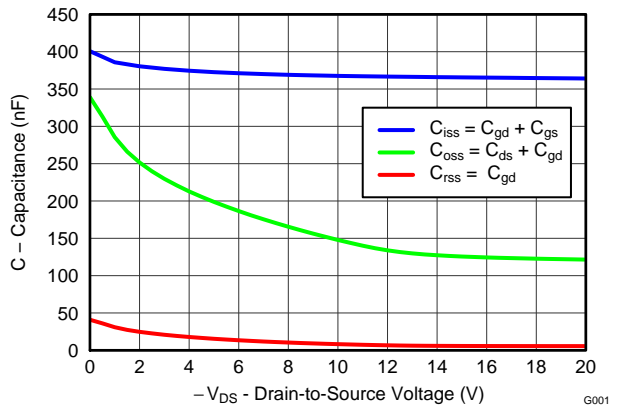


Figure 5. Capacitance

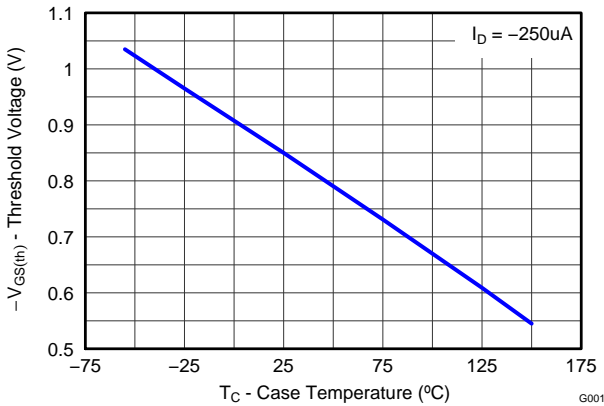


Figure 6. Threshold Voltage vs. Temperature

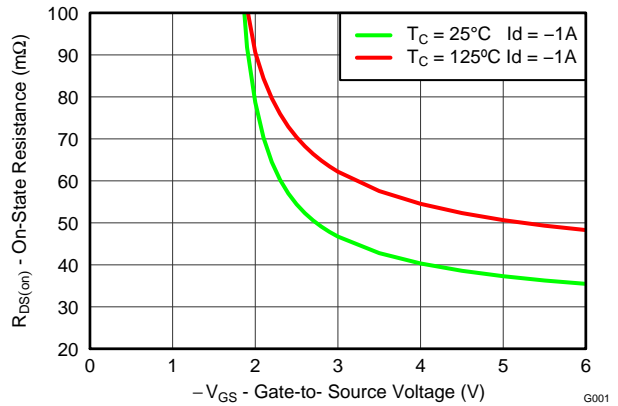


Figure 7. On-State Resistance vs. Gate-to-Source Voltage

TYPICAL MOSFET CHARACTERISTICS (continued)

($T_A = 25^\circ\text{C}$ unless otherwise stated)

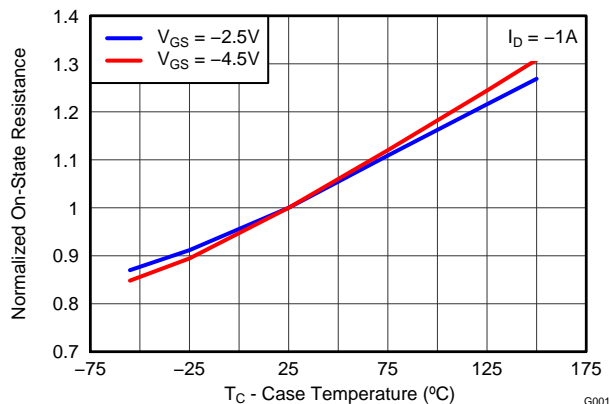


Figure 8. Normalized On-State Resistance vs. Temperature

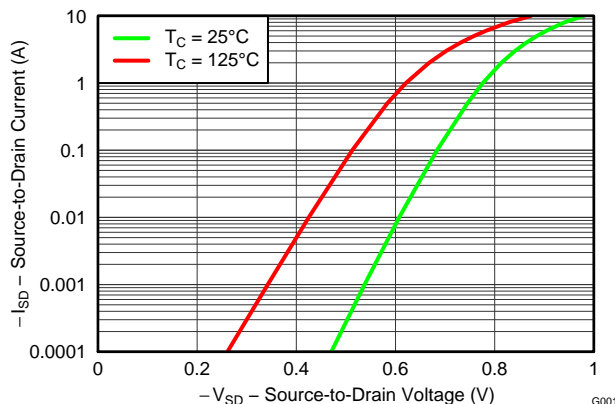


Figure 9. Typical Diode Forward Voltage

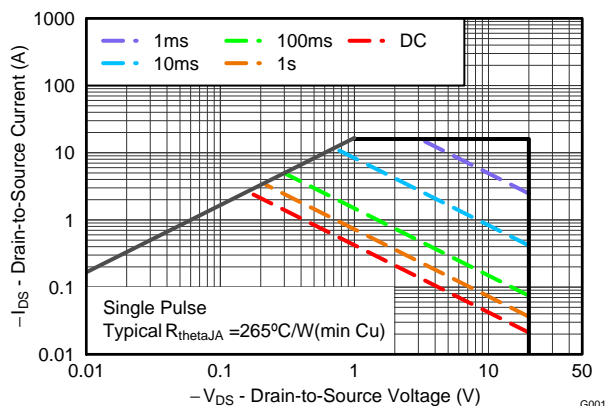


Figure 10. Maximum Safe Operating Area

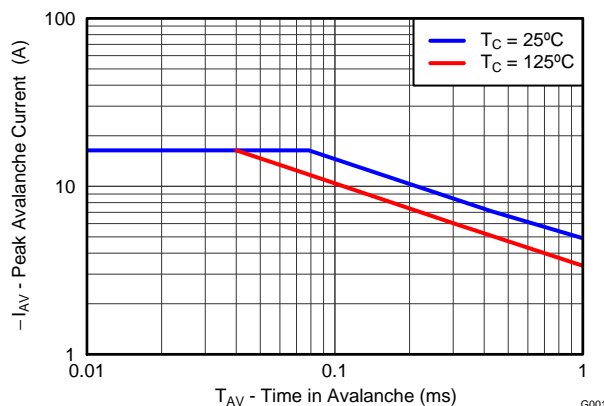


Figure 11. Single Pulse Unclamped Inductive Switching

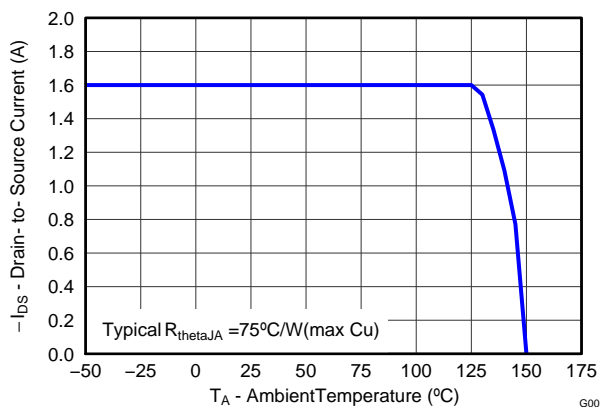
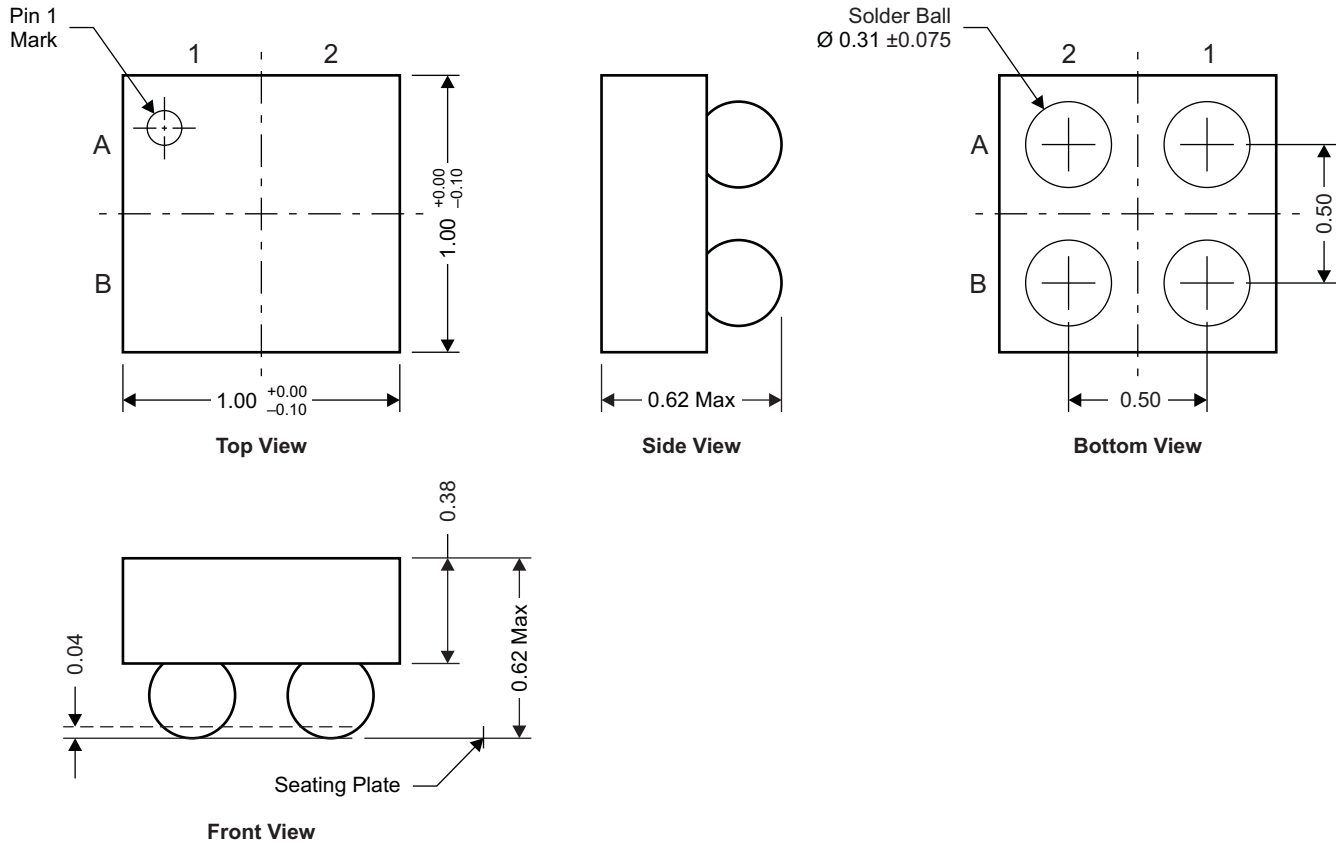


Figure 12. Maximum Drain Current vs. Temperature

MECHANICAL DATA

CSD25213W10 Package Dimensions



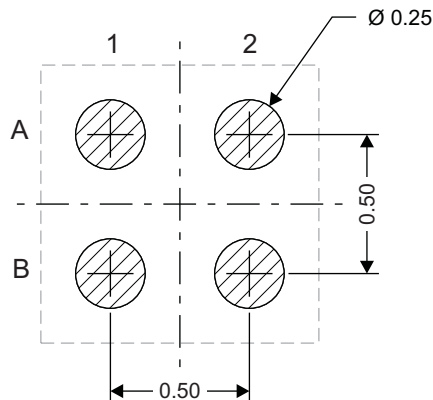
NOTE: All dimensions are in mm (unless otherwise specified)

M0151-01

Pin Configuration Table

POSITION	DESIGNATION
A1	Gate
B1	Drain
A2, B2	Source

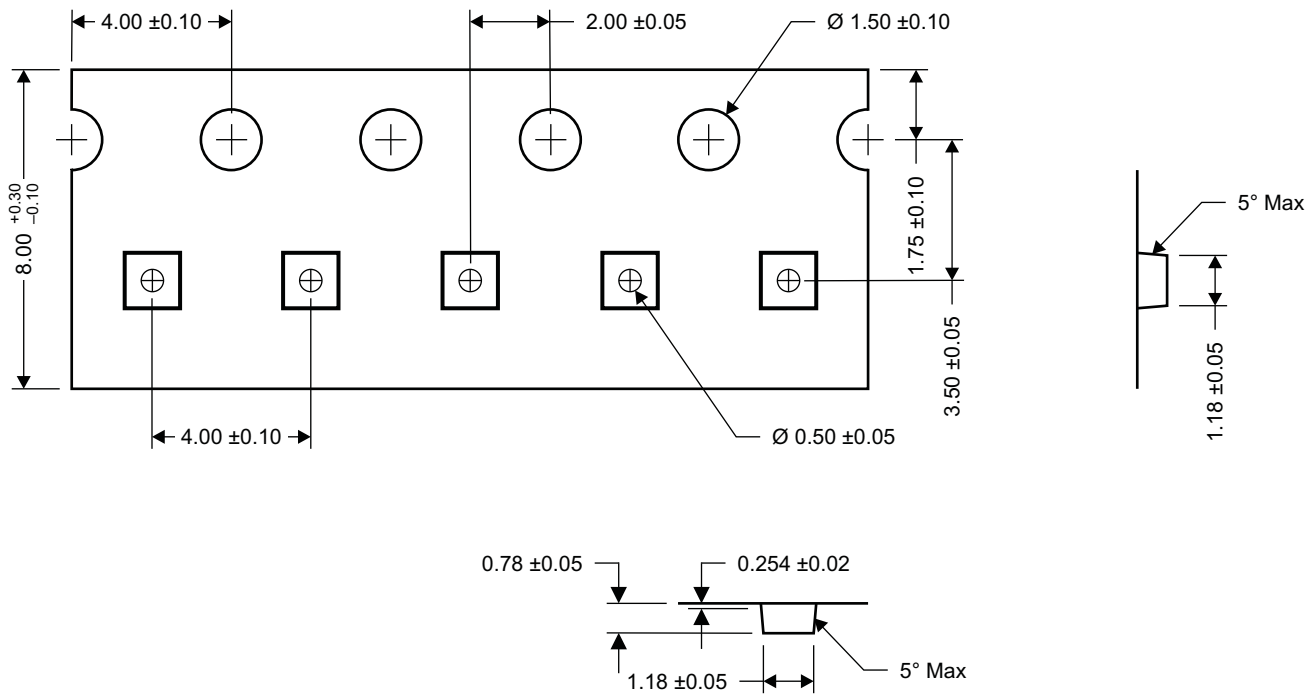
Land Pattern Recommendation



M0152-01

NOTE: All dimensions are in mm (unless otherwise specified)

Tape and Reel Information



- (1) All dimensions are in mm (unless otherwise specified)
- (2) Pin 1 will be oriented in the top left quadrant of the tape enclosure (closest to the carrier tape sprocket holes).

M0153-01

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD25213W10	ACTIVE	DSBGA	YZB	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-55 to 150	213	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

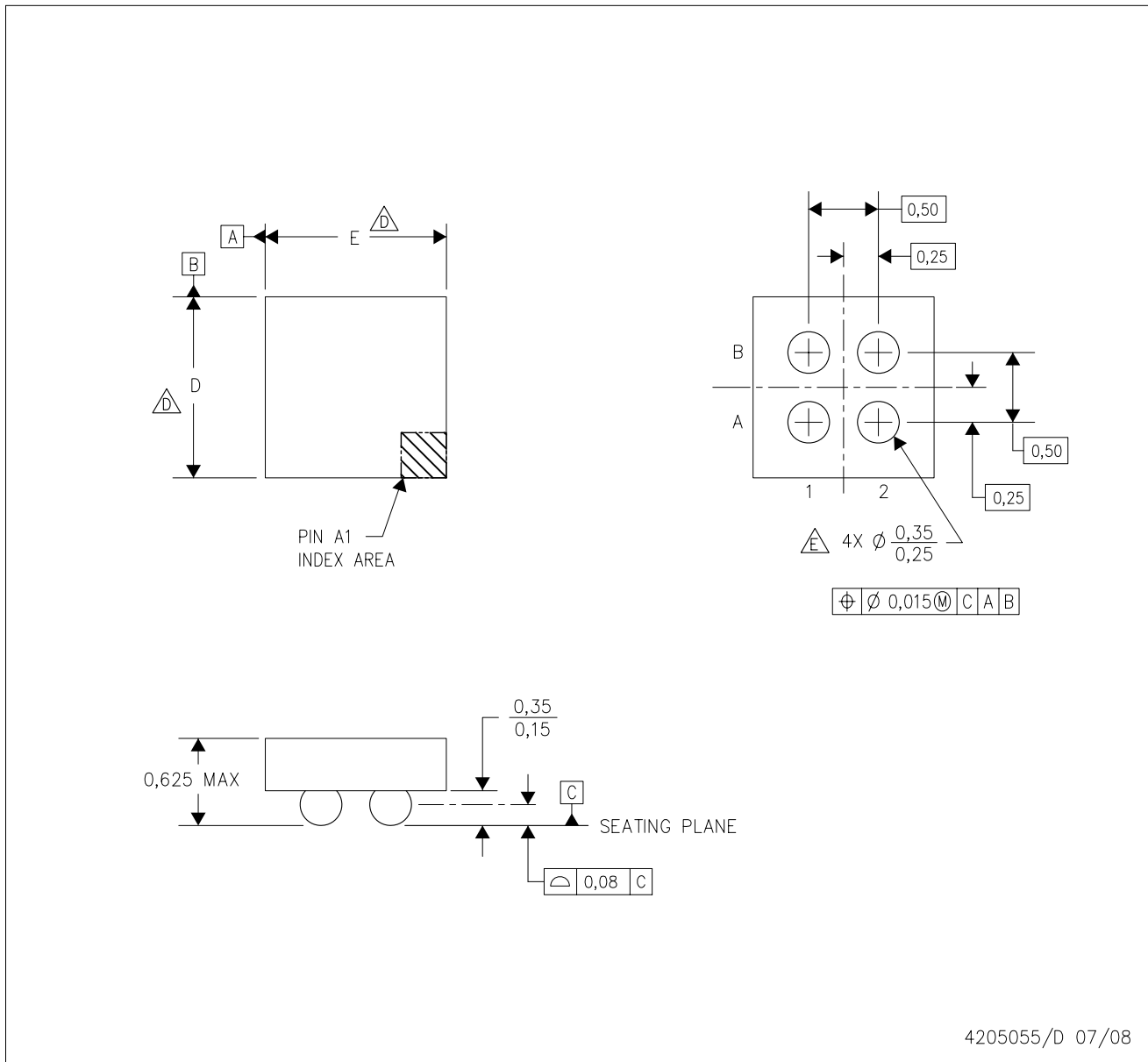
(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

YZB (S-XBGA-N4)

DIE-SIZE BALL GRID ARRAY



4205055/D 07/08

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. NanoFree™ package configuration.
 - $\triangle D$ Devices in YZB package can have dimension D ranging from 0.94 to 1.65 mm and dimension E ranging from 0.94 to 1.65 mm. To determine the exact package size of a particular device, refer to the device datasheet or contact a local TI representative.
 - E. Reference Product Data Sheet for array population.
2 x 2 matrix pattern is shown for illustration only.
 - F. This package contains lead-free balls.
Refer to YEB (Drawing #4204178) for tin-lead (SnPb) balls.

重要声明

德州仪器(TI) 及其下属子公司有权根据 JESD46 最新标准, 对所提供的产品和服务进行更正、修改、增强、改进或其它更改, 并有权根据 JESD48 最新标准中止提供任何产品和服务。客户在下订单前应获取最新的相关信息, 并验证这些信息是否完整且是最新的。所有产品的销售都遵循在订单确认时所提供的TI 销售条款与条件。

TI 保证其所销售的组件的性能符合产品销售时 TI 半导体产品销售条件与条款的适用规范。仅在 TI 保证的范围内, 且 TI 认为有必要时才会使用测试或其它质量控制技术。除非适用法律做出了硬性规定, 否则没有必要对每种组件的所有参数进行测试。

TI 对应用帮助或客户产品设计不承担任何义务。客户应对其使用 TI 组件的产品和应用自行负责。为尽量减小与客户产品和应用相关的风险, 客户应提供充分的设计与操作安全措施。

TI 不对任何 TI 专利权、版权、屏蔽作品权或其它与使用了 TI 组件或服务的组合设备、机器或流程相关的 TI 知识产权中授予的直接或间接侵权作出任何保证或解释。TI 所发布的与第三方产品或服务有关的信息, 不能构成从 TI 获得使用这些产品或服务的许可、授权、或认可。使用此类信息可能需要获得第三方的专利权或其它知识产权方面的许可, 或是 TI 的专利权或其它知识产权方面的许可。

对于 TI 的产品手册或数据表中 TI 信息的重要部分, 仅在没有对内容进行任何篡改且带有相关授权、条件、限制和声明的情况下才允许进行复制。TI 对此类篡改过的文件不承担任何责任或义务。复制第三方的信息可能需要服从额外的限制条件。

在转售 TI 组件或服务时, 如果对该组件或服务参数的陈述与 TI 标明的参数相比存在差异或虚假成分, 则会失去相关 TI 组件或服务的所有明示或暗示授权, 且这是不正当的、欺诈性商业行为。TI 对任何此类虚假陈述均不承担任何责任或义务。

客户认可并同意, 尽管任何应用相关信息或支持仍可能由 TI 提供, 但他们将独自负责满足与其产品及其应用中使用 TI 产品相关的所有法律、法规和安全相关要求。客户声明并同意, 他们具备制定与实施安全措施所需的全部专业技术和知识, 可预见故障的危险后果、监测故障及其后果、降低有可能造成人身伤害的故障的发生机率并采取适当的补救措施。客户将全额赔偿因在此类安全关键应用中使用任何 TI 组件而对 TI 及其代理造成的任何损失。

在某些场合中, 为了推进安全相关应用有可能对 TI 组件进行特别的促销。TI 的目标是利用此类组件帮助客户设计和创立其特有的可满足适用的功能安全性标准和要求的终端产品解决方案。尽管如此, 此类组件仍然服从这些条款。

TI 组件未获得用于 FDA Class III (或类似的生命攸关医疗设备) 的授权许可, 除非各方授权官员已经达成了专门管控此类使用的特别协议。

只有那些 TI 特别注明属于军用等级或“增强型塑料”的 TI 组件才是设计或专门用于军事/航空应用或环境的。购买者认可并同意, 对并非指定面向军事或航空航天用途的 TI 组件进行军事或航空航天方面的应用, 其风险由客户单独承担, 并且由客户独自负责满足与此类使用相关的所有法律和法规要求。

TI 已明确指定符合 ISO/TS16949 要求的产品, 这些产品主要用于汽车。在任何情况下, 因使用非指定产品而无法达到 ISO/TS16949 要求, TI 不承担任何责任。

	产品		应用
数字音频	www.ti.com.cn/audio	通信与电信	www.ti.com.cn/telecom
放大器和线性器件	www.ti.com.cn/amplifiers	计算机及周边	www.ti.com.cn/computer
数据转换器	www.ti.com.cn/dataconverters	消费电子	www.ti.com.cn/consumer-apps
DLP® 产品	www.dlp.com	能源	www.ti.com.cn/energy
DSP - 数字信号处理器	www.ti.com.cn/dsp	工业应用	www.ti.com.cn/industrial
时钟和计时器	www.ti.com.cn/clockandtimers	医疗电子	www.ti.com.cn/medical
接口	www.ti.com.cn/interface	安防应用	www.ti.com.cn/security
逻辑	www.ti.com.cn/logic	汽车电子	www.ti.com.cn/automotive
电源管理	www.ti.com.cn/power	视频和影像	www.ti.com.cn/video
微控制器 (MCU)	www.ti.com.cn/microcontrollers		
RFID 系统	www.ti.com.cn/rfidsys		
OMAP应用处理器	www.ti.com.cn/omap		
无线连通性	www.ti.com.cn/wirelessconnectivity	德州仪器在线技术支持社区	www.deyisupport.com

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2016, Texas Instruments Incorporated